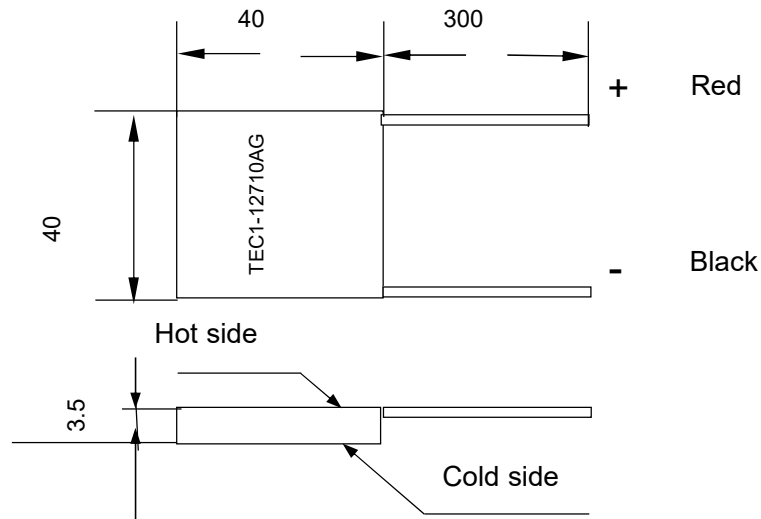


THC1-12710 Technical Specifications for Semiconductor Refrigeration Chips

1. Dimensions

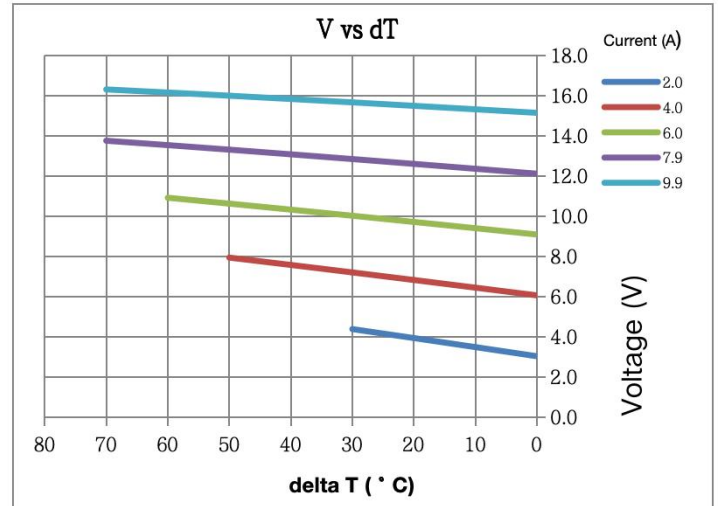
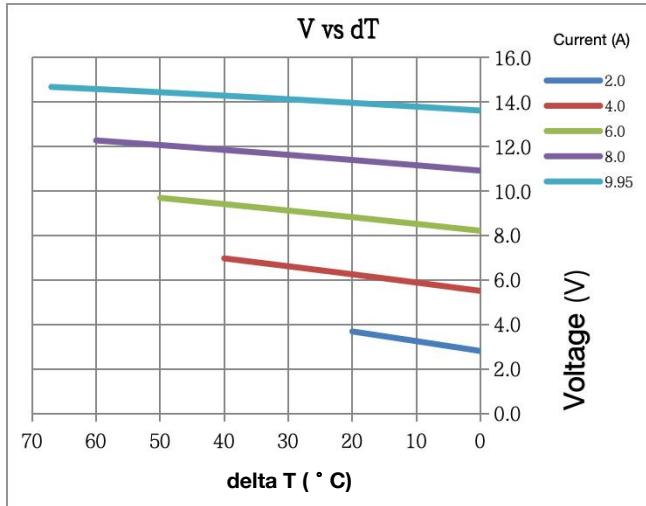


2. Basic electrical performance index

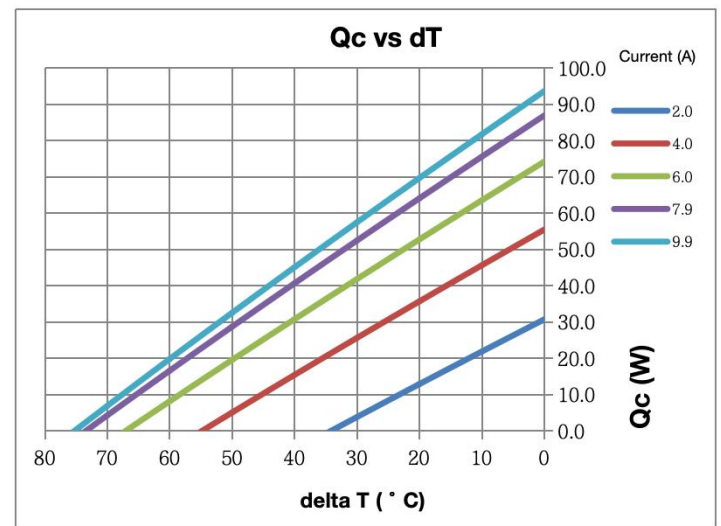
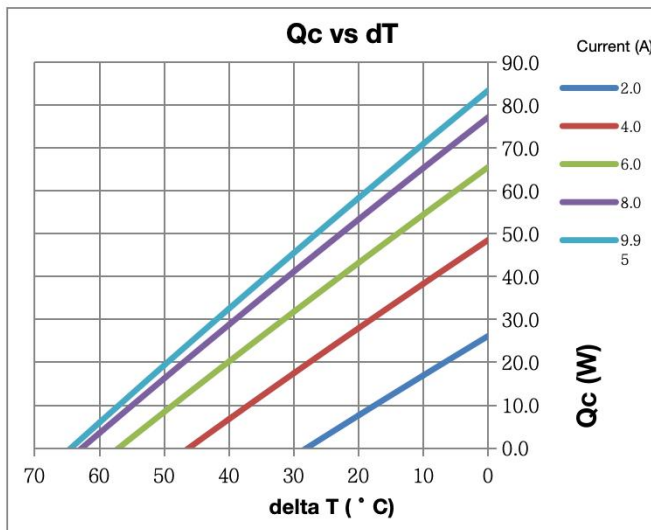
► Ambient Temperature (°C)	27	Lead wire	20AWG, L=300mm, Or ordered by customer
Maximum cooling power (Watts)	88.9	Thickness (mm)	3.5±0.1
△T-max (°C)	≥66	Flatness & Parallelis (mm)	≤0.05
I _{max} (Amps)	10	Melting point of Solder (°C)	138
V _{max} (Volts)	15.4	Ceramic Material	Alumina (Al ₂ O ₃)
AC resistance (Ohms)	1.15~1.3	Mark	TEC1-12710AG
Seal	silica gel 704	Package	500PCS per carton

TEC1-127-10 Refrigeration Device Relationship Curve

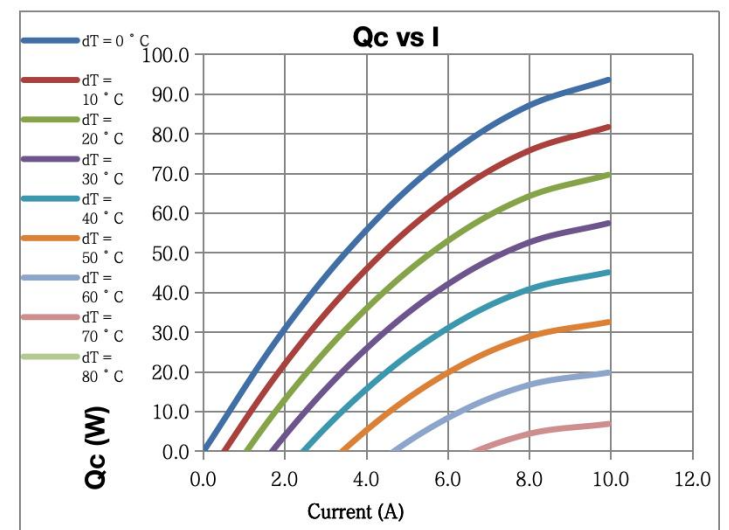
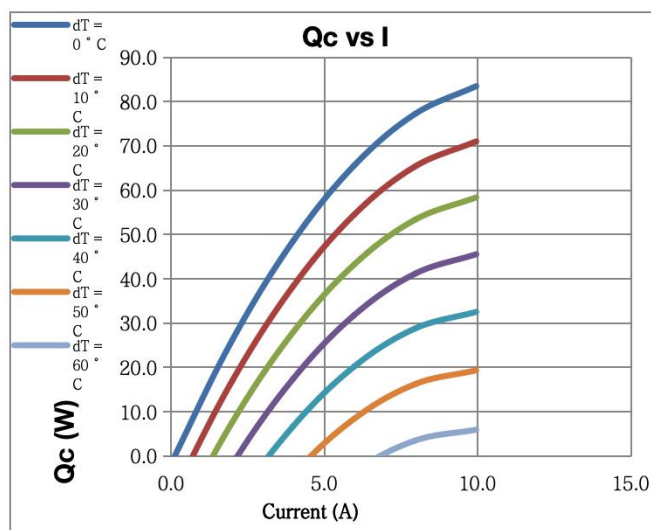
Performance curve when hot surface temperature $T_h=27^\circ\text{C}$ Performance curve when hot surface temperature $T_h=50^\circ\text{C}$



Performance diagram of voltage changing with temperature difference under different currents $V=f(\Delta T)$



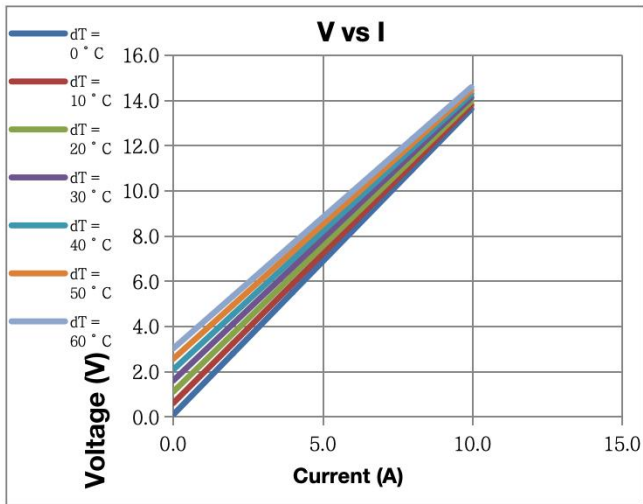
Performance diagram of cooling with different currents (Q_d)



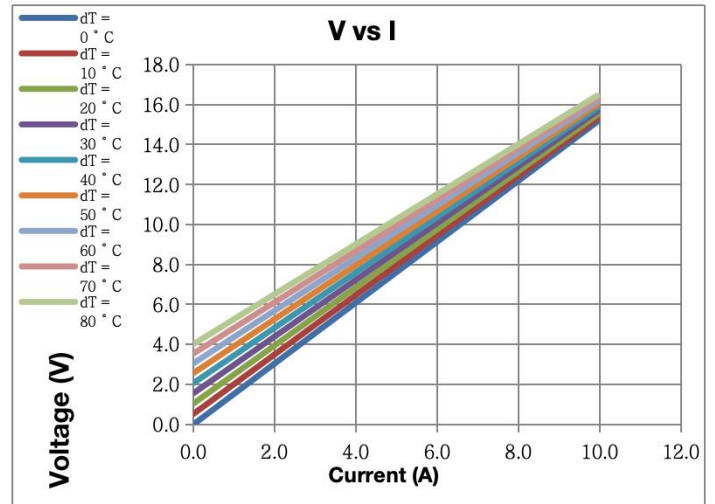
Performance diagram of cooling capacity changes with voltage under different temperature differences $Q_c=f(I)$

TEC1-127-10 Refrigeration Device Relationship Curve

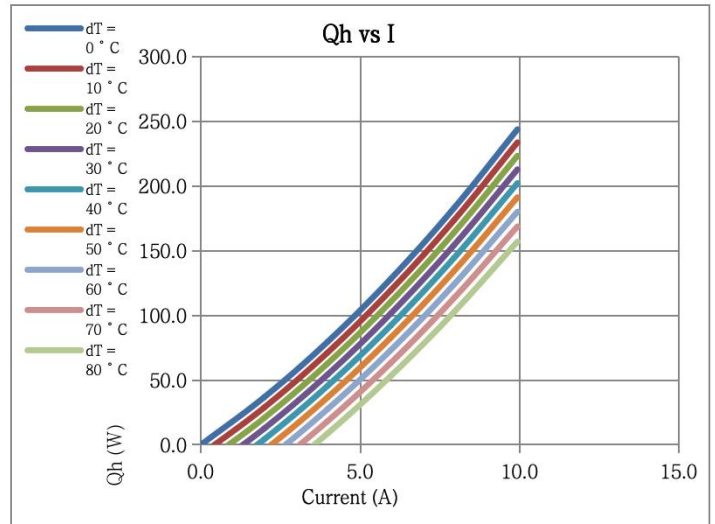
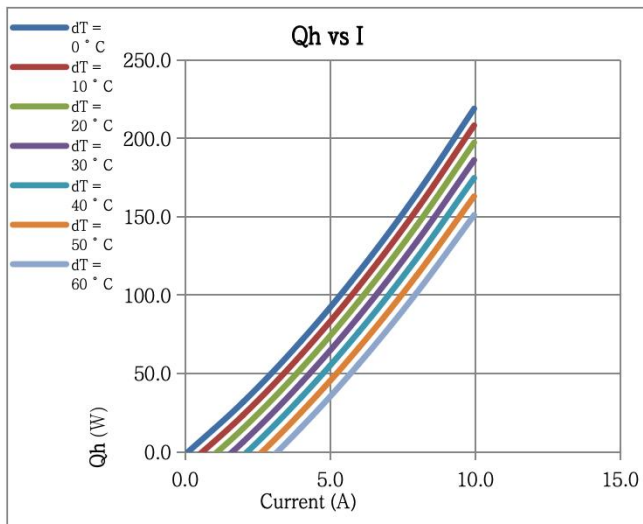
Performance curve when hot surface temperature $T_h=27^\circ\text{C}$



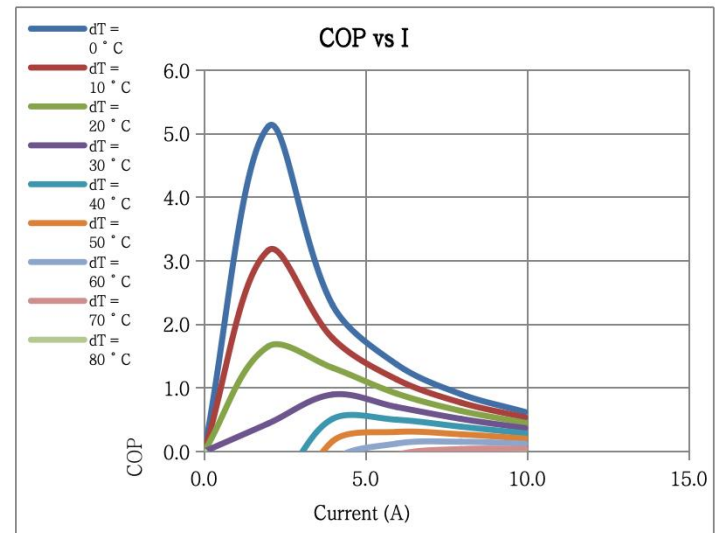
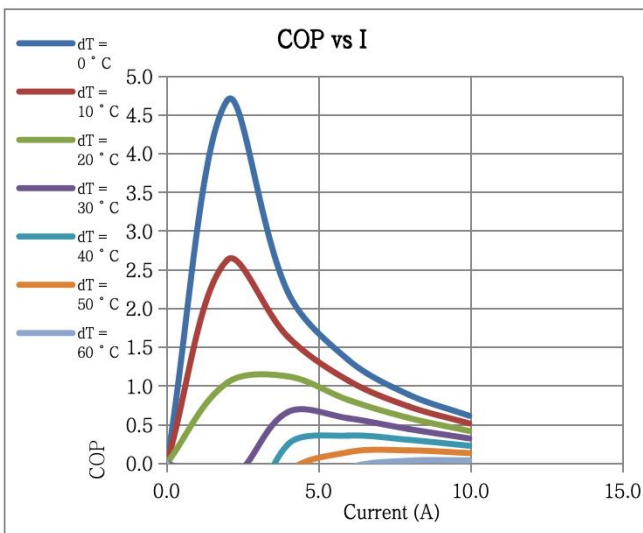
Performance curve when hot surface temperature $T_h=50^\circ\text{C}$



Performance diagram of voltage changing with current under different temperature differences $V = f(I)$



Performance diagram of total heat changes with current under different temperature differences $Q_h = f(I)$



Performance diagram of energy efficiency ratio changes with current under different temperature differences $\text{COP} = f(I)$